

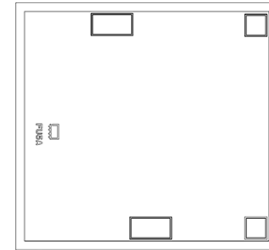
# Ultra Low Noise, Low Current, Shutdown Monolithic Amplifier Die

## PMA2-133LN-D+

50Ω 10 to 13 GHz

### The Big Deal

- Ultra-low noise figure, 1.3 dB
- Low Current, 13 mA at 3V and 29mA at 5V
- Excellent ESD protection, Class 1C
- Shutdown feature



### Product Overview

Mini-Circuits' PMA2-133LN-D+ is an E-PHEMT based, ultra-low noise MMIC amplifier die. The model offers a unique combination of low current consumption, low noise and high IP3, making it an ideal for sensitive, high-dynamic-range receiver applications. This design operates at both 3V & 5V supply, is well matched for 50Ω systems.

### Key Features

Feature	Advantages
Ultra-low noise, 1.3 dB at 11 GHz	Enables lower system noise figure performance.
High IP3, 28.6 dBm typ. at 11 GHz	The combination of low noise and high IP3 makes the PMA2-133LN-D+ ideal for use in low noise receiver front end (RFE) as it gives the user the advantages of sensitivity and two-tone IM performance at both ends of the dynamic range.
Support Low operating voltage, 3V&5V	Usable in battery operated systems.
Low current consumption, 13 mA at 3V 29 mA at 5V	Enables prolonged battery life.
Shutdown feature ( $V_{en}=0V$ , $V_{DD}=3/5V$ )	Saves DC power consumption when it is not required.
Separate pads for $V_{DD}$ and RF-OUT	Built-in RF-choke separates $V_{DD}$ and RF-OUT ports, minimizing external components, cost and saving PCB space.
Excellent ESD protection, Class 1C	Robust ESD performance eliminates the need for external ESD protection circuits, saving PCB space, minimizing noise figure degradation, and reducing cost.
Unpackaged Die	Enables the user to integrate the amplifier directly into hybrids



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### Product Features

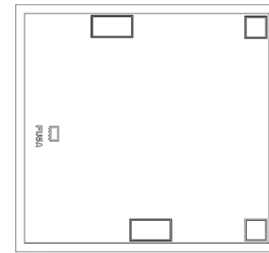
- Low noise figure, 1.3 dB at 11 GHz
- Low current, 13 mA at 3V, 29 mA typ. at 5V
- Excellent ESD protection Class 1C
- Shutdown feature

### Typical Applications

- Satellite communication
- Military Radar
- VSAT
- Point to Point
- Radio Astronomy

### General Description

Mini-Circuits' PMA2-133LN-D+ is an E-PHEMT based, ultra-low noise MMIC amplifier die. The model offers a unique combination of low current consumption, low noise and high IP3, making it an ideal for sensitive, high-dynamic-range receiver applications. This design operates at both 3V & 5V supply, is well matched for 50Ω systems.

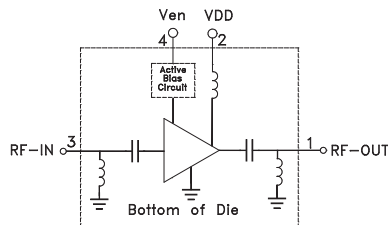


#### +RoHS Compliant

The +Suffix identifies RoHS Compliance. See our web site for RoHS Compliance methodologies and qualifications

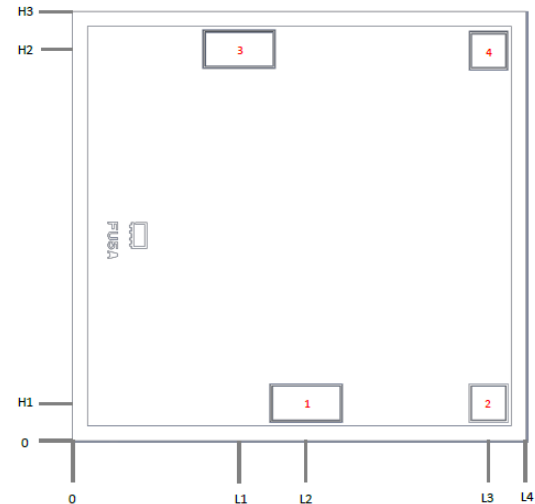
Ordering Information: Refer to Last Page

### Simplified Schematic and Pad description



Pad #	Function	Description
1	RF-OUT	RF Output pad. This pad requires the use of an external DC blocking capacitor.
2	V <sub>DD</sub>	DC Supply pad, Connect to external DC power supply.
3	RF-IN	RF Input pad. This pad requires the use of an external DC blocking capacitor.
4	Ven	Gain or shutdown model enable voltage pad. Connect to VDD for Gain mode operation. Connect to Ground to shutdown the amplifier.
Bottom of Die	GND	Connections to Ground.

### Bonding Pad Position



Dimensions in μm, Typical

L1	L2	L3	L4	H1	H2	H3	
345	484	862	940	78	812	890	
Thickness		Die size		Bond pad #1 and #3 Size		Bond pad #2 and #4 Size	
100		940 x 890		139 x 69		69 x 69	

**Electrical Specifications<sup>1</sup> at 25°C, 3V&5V, and 50 ohms unless noted**

Parameter	Condition (GHz)	3V			5V	Units
		Min.	Typ.	Max.	Typ.	
Frequency Range		10		13		GHz
Noise Figure	10.0		1.4		1.5	dB
	10.7		1.4		1.3	
	11.0		1.4		1.3	
	12.0		1.5		1.4	
	13.0		1.6		1.5	
Gain	10.0		14.1		15.3	dB
	10.7		14.1		15.3	
	11.0		14.1		15.3	
	12.0		14.1		15.6	
	13.0		14.0		15.8	
Reverse Isolation	11.0		22.7		23.3	dB
Input Return Loss	10.0		13		16	dB
	10.7		14		17	
	11.0		14		17	
	12.0		17		21	
	13.0		27		24	
Output Return Loss	10.0		18		14	dB
	10.7		16		12	
	11.0		16		12	
	12.0		26		18	
	13.0		13		18	
Output Power at 1dB Compression	10.0		8.4		13.3	dBm
	10.7		9.4		14.4	
	11.0		8.9		13.5	
	12.0		8.5		13.1	
	13.0		7.1		11.5	
Output IP3 Pout=-10 dBm/tone	10.0		23.4		27.9	dBm
	10.7		23.7		29.3	
	11.0		23.6		28.6	
	12.0		23.8		28.8	
	13.0		23.5		28.9	
Device Operating Voltage (V <sub>DD</sub> ) <sup>3</sup>			3.0		5.0	V
Device Operating Current (I <sub>DD</sub> )			13		29	mA
Device Current Variation vs. Temperature <sup>2</sup>			-10		-53	µA/°C
Device Current Variation vs. Voltage			0.0079		0.0076	mA/mV
Thermal Resistance, junction-to-ground lead			124		118	°C/W

<sup>1</sup> Measured on Mini-Circuits Characterization test board. Die is packaged in 2x2 MCLP and soldered on TB-991+. See Characterization Test Circuit (Fig. 1)

<sup>2</sup> (Current at 85°C - Current at -45°C)/130

<sup>3</sup> V<sub>DD</sub> is connected to Ven.

**Absolute Maximum Ratings<sup>4</sup>**

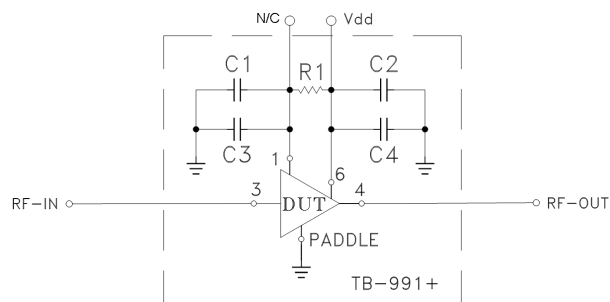
Parameter	Ratings
Operating Temperature (ground lead)	-40°C to 85°C
Total Power Dissipation	0.31W
Input Power (CW)	+19 dBm (5minutes max) +10 dBm (continuous)
DC Voltage	+7.7V

Note:

<sup>4</sup> Permanent damage may occur if any of these limits are exceeded.  
Electrical maximum ratings are not intended for continuous normal operation.



**Recommended Application and Characterization Test Circuit**



For Gain Mode Operation:

Component	Size	Value	Manufacturer	P/N
C1, C2	0402	0.1uF	Murata	GRM155R71C104KA88D
C3, C4	0402	100pF	Murata	GRM1555C1H101J01D
R1	0402	0 ohms	KOA	RK73Z1JTTD

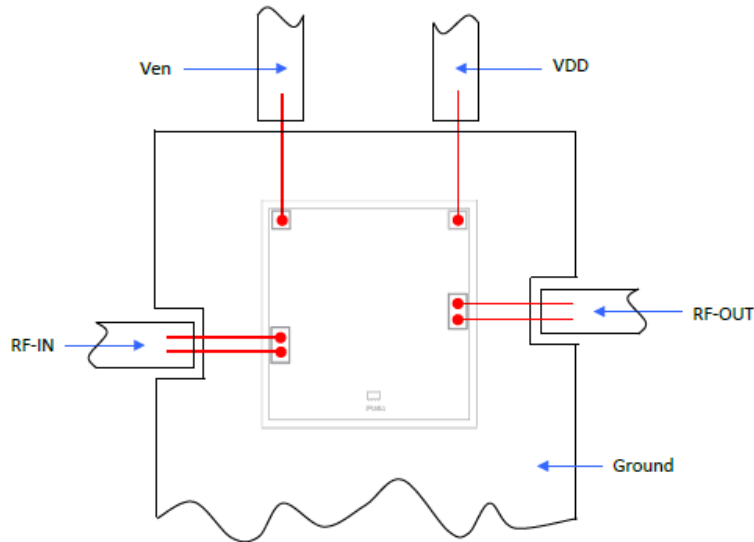
Fig 1. Application and Characterization Circuit

This block diagram is used for DUT characterization in Gain Mode operation. (Die is packaged in 2x2mm MCLP and soldered on Mini-Circuits Characterization test board TB-991+). For DUT pad description, please see PMA2-133LN+ data sheet. Gain, Return loss, Output power at 1dB compression (P1dB), Output IP3 (OIP3) and noise figure measured using Agilent's N5242A PNA-X microwave network analyzer.

Conditions:

1. Gain and Return loss: Pin= -25dBm
2. Output IP3 (OIP3): Two tones, spaced 1 MHz apart, -10 dBm/tone at output.

## Assembly Diagram



## Assembly and Handling Procedure

- Storage**  
 Dice should be stored in a dry nitrogen purged desiccators or equivalent.
- ESD**  
 MMIC E-PHEMT amplifier dice are susceptible to electrostatic and mechanical damage. Die are supplied in antistatic protected material, which should be opened in clean room conditions at an appropriately grounded anti-static workstation. Devices need careful handling using correctly designed collets, vacuum pickup tips or sharp antistatic tweezers to deter ESD damage to dice.
- Die Attach**  
 The die mounting surface must be clean and flat. Using conductive silver filled epoxy, recommended epoxies are DieMat DM6030HK-PT/H579 or Ablestik 84-1LMISR4. Apply sufficient epoxy to meet required epoxy bond line thickness, epoxy fillet height and epoxy coverage around total die periphery. Parts shall be cured in a nitrogen filled atmosphere per manufacturer's cure condition. It is recommended to use antistatic die pick up tools only.
- Wire Bonding**  
 Bond pad openings in the surface passivation above the bond pads are provided to allow wire bonding to the dice gold bond pads. Thermosonic bonding is used with minimized ultrasonic content. Bond force, time, ultrasonic power and temperature are all critical parameters. Suggested wire is pure gold, 1 mil diameter. Bonds must be made from the bond pads on the die to the package or substrate. All bond wires should be kept as short as low as reasonable to minimize performance degradation due to undesirable series inductance.

<b>Additional Detailed Technical Information</b> <i>additional information is available on our dash board.</i>	
<b>Performance Data</b>	Data Table
	Swept Graphs
	S-Parameter (S2P Files) Data Set with and without port extension(.zip file)
<b>Case Style</b>	Die
<b>Die Ordering and packaging information</b>	Quantity, Package <span style="float:right">Model No.</span>
	Small, Gel - Pak: 5,10,50,100 KGD* <span style="float:right">PMA2-133LN-DG+</span> Medium†, Partial wafer: KGD* <800 <span style="float:right">PMA2-133LN-DP+</span> Large†, Full Wafer <span style="float:right">PMA2-133LN-DF+</span>
	†Available upon request contact sales representative
	Refer to <a href="#">AN-60-067</a>
<b>Environmental Ratings</b>	ENV80

\*Known Good Dice ("KGD") means that the dice in question have been subjected to Mini-Circuits DC test performance criteria and measurement instructions and that the parametric data of such dice fall within a predefined range. While DC testing is not definitive, it does help to provide a higher degree of confidence that dice are capable of meeting typical RF electrical parameters specified by Mini-Circuits.

**ESD Rating\*\***

Human Body Model (HBM): Class 1C (pass 1000V) in accordance with ANSI/ESD STM 5.1 - 2001

\*\* Tested in industry standard 2mm x 2mm MCLP

**Additional Notes**

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